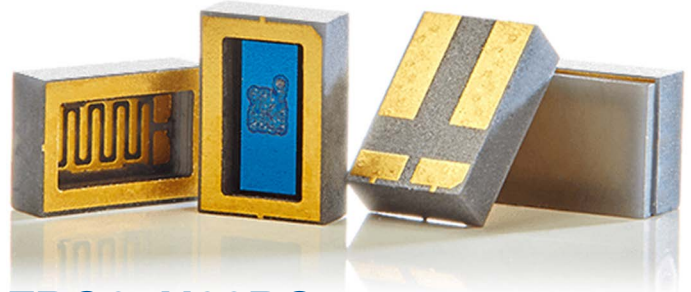


### Features

- Low  $R_{DS(on)}$
- Ultra-low  $Q_G$  For High Efficiency
- Logic Level
- Light Weight
- Compact Hermetic Package
- Source Sense Pin
- Total Ionizing Dose LDR Immune
- Total Ionizing Dose HDR Immune
- Single Event Effect (SEE) Hardened
  - SEE immunity for LET of 83.7 MeV/mg/cm<sup>2</sup> with  $V_{DS}$  up to 100% of rated Breakdown
- Neutron
  - Maintains Pre-Rad specification for up to  $4 \times 10^{15}$  Neutrons/cm<sup>2</sup>



### FBG04N30BC

**Rad-Hard eGaN® 40 V, 30 A, 11 mΩ Surface Mount (FSMD-B)**

### Description

EPC Space FSMD-B series of eGaN® power switching HEMTs have been specifically designed for critical applications in Space and other the high reliability environments. These devices have exceptionally high electron mobility and a low temperature coefficient resulting in very low  $R_{DS(on)}$  values. The lateral structure of the die provides for very low gate charge ( $Q_G$ ) and extremely fast switching times. These features enable faster power supply switching frequencies resulting in higher power densities, higher efficiencies and more compact packaging.

### Applications

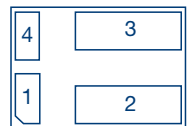
- Satellite and Avionics
- Deep Space Probes
- High Speed Rad-Hard DC-DC Conversion
- Rad-Hard Motor Controllers

### Thermal Characteristics

Symbol	Parameter-Conditions	Value	Units
$R_{\theta JA}$	Thermal Resistance Junction to Ambient (Note 3)	35	°C/W
$R_{\theta JC}$	Thermal Resistance Junction to Case	2.25	

### I/O Pin Assignment (Bottom View)

Pin	Symbol	Description
1	G	Gate
2	D	Drain
3	S	Source
4	SS	Source Sense



### Absolute Maximum Rating ( $T_C = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter-Conditions	Value	Units
$V_{DS}$	Drain to Source Voltage (Note 1)	40	V
$I_D$	Continuous Drain Current $I_D$ @ $V_{GS} = 4.5\text{ V}$ , $T_C = 25^\circ\text{C}$	30	A
$I_{DM}$	Single-Pulse Drain Current $t_{pulse} \leq 80\ \mu\text{s}$	120	
$V_{GS}$	Gate to Source Voltage (Note 2)	+6 / -4	V
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	-55 to +150	°C
$T_{sol}$	Package Mounting Surface Temperature	260	
ESD	ESD Class	1A ( $\Delta A$ )	
Weight	Device Weight	0.135	g

**Electrical Characteristics** ( $T_C = 25^\circ\text{C}$  unless otherwise noted. Typical (TYP) values are for reference only.)

Parameter	Symbol	Test Conditions	MIN	TYP	MAX	Units	
Minimum Drain to Source Voltage	$V_{\text{DSMIN}}$	$V_G = 0\text{ V}$	40			V	
Drain to Source Leakage	$I_{\text{DSS}}$	$V_{\text{DS}} = 40\text{ V}$ $V_{\text{GS}} = 0\text{ V}$		26	400	$\mu\text{A}$	
				300	1000		
Gate to Source Forward Leakage	$I_{\text{GSSF}}$	$V_{\text{GS}} = 5\text{ V}$		100	500	$\mu\text{A}$	
Gate to Source Reverse Leakage	$I_{\text{GSSR}}$	$V_{\text{GS}} = -4\text{ V}$		50	400		
Gate to Source Threshold Voltage	$V_{\text{GS(th)}}$	$V_{\text{DS}} = V_{\text{GS}}, I_{\text{D}} = 5\text{ mA}$	$T_C = 25^\circ\text{C}$	0.8	1	2.5	V
Gate to Source Threshold Voltage Temperature Coefficient	$\Delta V_{\text{GS(th)}}/\Delta T$		$-55^\circ\text{C} < T_A < 150^\circ\text{C}$		[1.5]		$\text{mV}/^\circ\text{C}$
Drain to Source Resistance (Note 4)	$R_{\text{DS(on)}}$	$I_{\text{D}} = 30\text{ A}, V_{\text{GS}} = 5\text{ V}$	$T_C = 25^\circ\text{C}$		9	11	$\text{m}\Omega$
Source to Drain Forward Voltage	$V_{\text{SD}}$	$I_{\text{S}} = 0.5\text{ A}, V_{\text{G}} = 0\text{ V}$	$T_C = 25^\circ\text{C}$		2.5		V

**Dynamic Characteristics** ( $T_C = 25^\circ\text{C}$  unless otherwise noted. Typical (TYP) values are for reference only.)

Parameter	Symbol	Test Conditions	MIN	TYP	MAX	Units
Input Capacitance	$C_{\text{ISS}}$	$f = 1\text{ MHz}, V_{\text{DS}} = 20\text{ V}, V_{\text{GS}} = 0\text{ V}$		1100	1300	$\text{pF}$
Output Capacitance	$C_{\text{OSS}}$			650	900	
Reverse transfer Capacitance	$C_{\text{RSS}}$			30	60	
Gate Resistance (Note 5)	$R_{\text{G}}$	$f = 1\text{ MHz}, V_{\text{DS}} = V_{\text{GS}} = 0\text{ V}$		1.1		$\Omega$
Total Gate Charge (Note 6)	$Q_{\text{G}}$	$I_{\text{D}} = 30\text{ A}, V_{\text{GS}} = 5\text{ V}, V_{\text{DS}} = 20\text{ V}$		8.9	11.4	$\text{nC}$
Gate to Drain Charge (Note 6)	$Q_{\text{GD}}$			2.1	3.0	
Gate to Source Charge (Note 6)	$Q_{\text{GS}}$			2.3	3.1	
Output Charge (Note 5)	$Q_{\text{OSS}}$	$V_{\text{GS}} = 0\text{ V}, V_{\text{DS}} = 20\text{ V}$		22	26	
Source to Drain Recovery Charge	$Q_{\text{RR}}$	$I_{\text{D}} = 30\text{ A}, V_{\text{DS}} = 20\text{ V}$		<1		

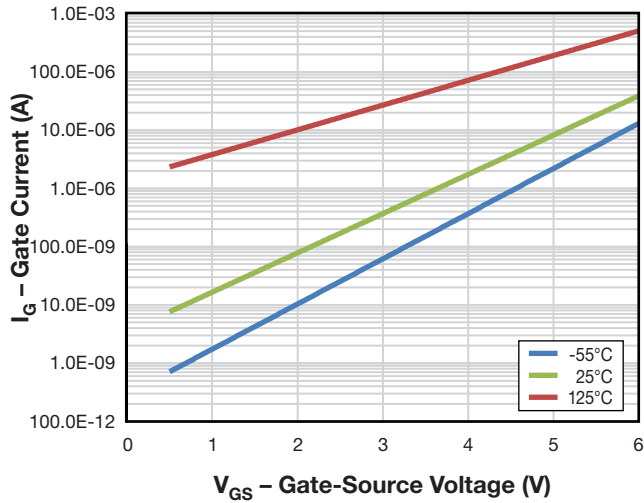


Figure 1. Typical Gate-Source Leakage Current vs. Ambient Temperature

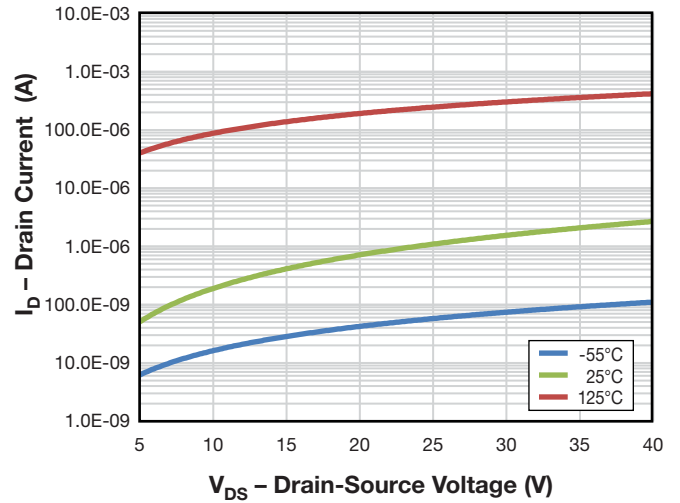


Figure 2. Typical Drain-Source Leakage Current vs. Ambient Temperature

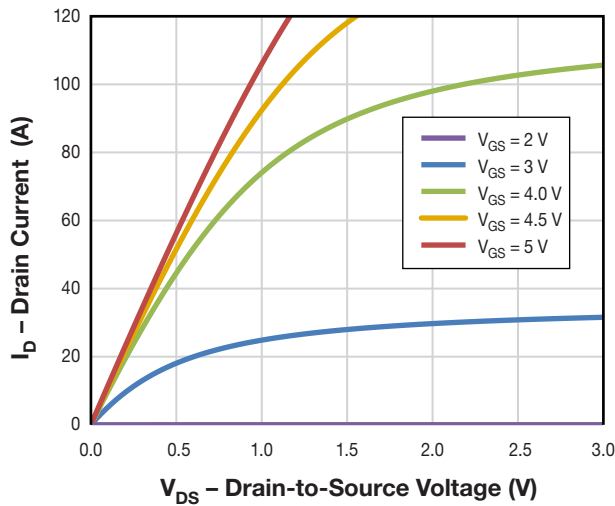


Figure 3. Typical Output Characteristics at  $25^\circ\text{C}$

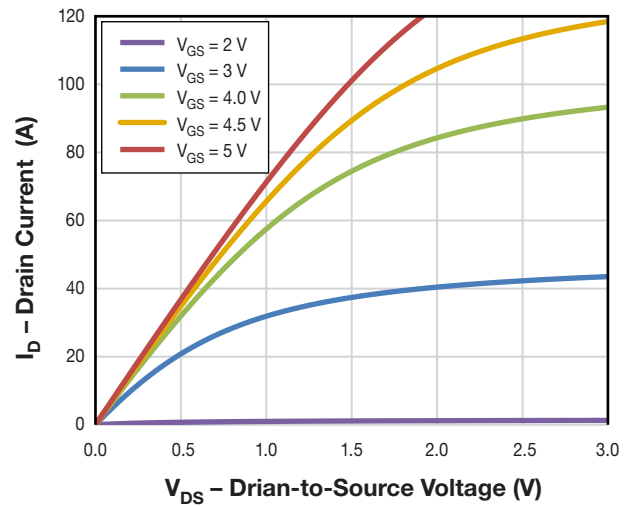


Figure 4. Typical Output Characteristics at  $125^\circ\text{C}$

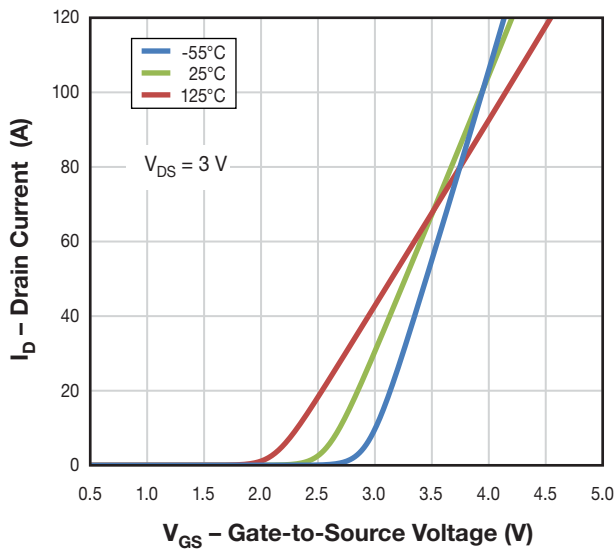


Figure 5. Typical Transfer Characteristics

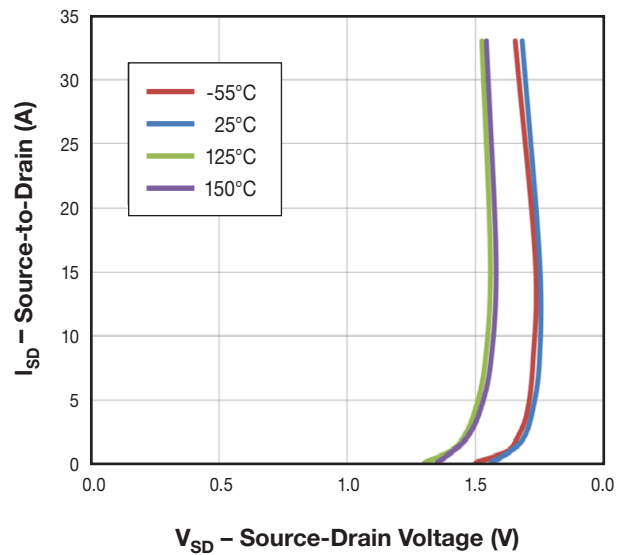


Figure 6. Reverse Drain-Source Characteristics

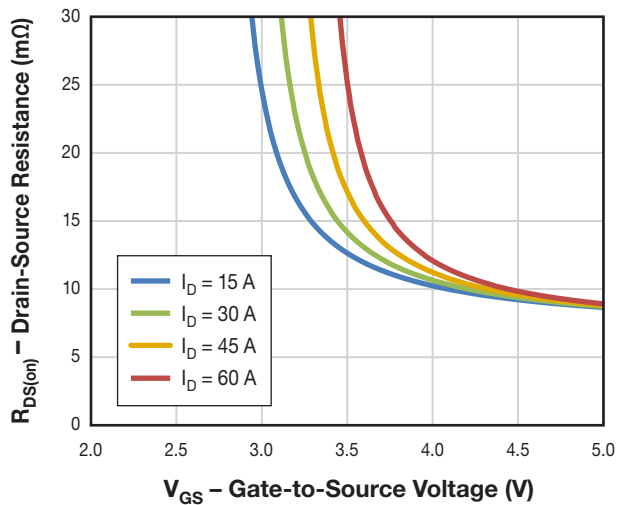


Figure 7.  $R_{DS(on)}$  vs  $V_{GS}$  for Various Drain Currents

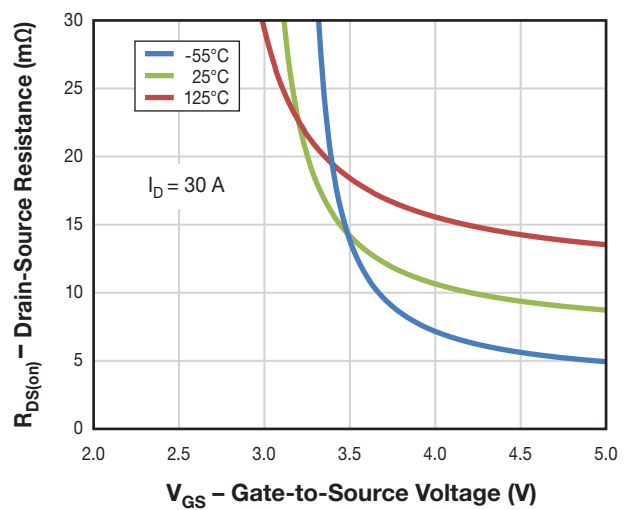


Figure 8.  $R_{DS(on)}$  vs  $V_{GS}$  for Various Temperatures

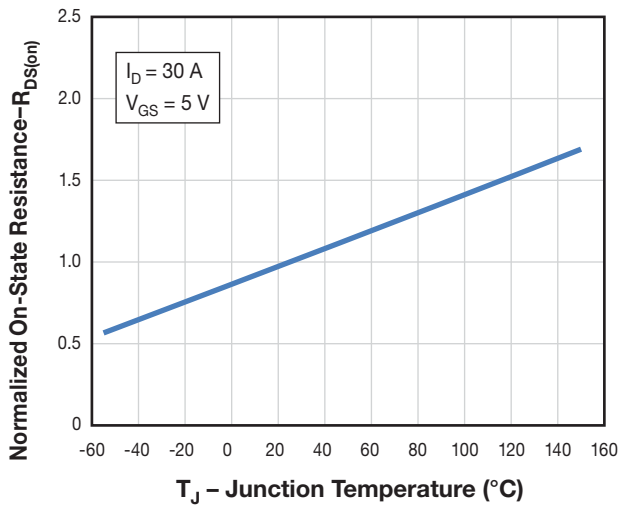


Figure 9. Normalized On-State Resistance vs. Temperature

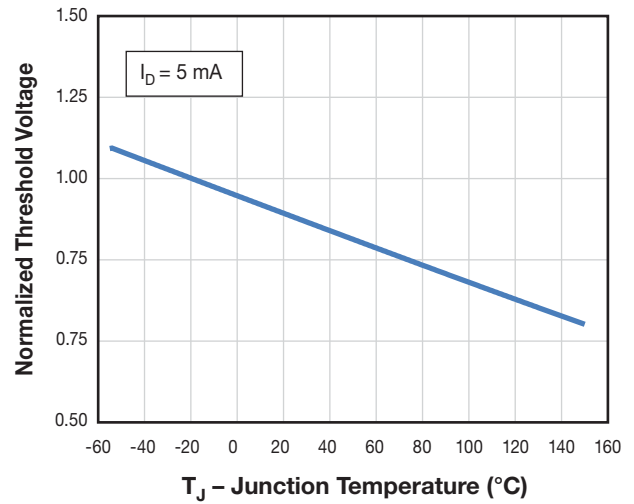


Figure 10. Normalized Threshold Voltage vs. Temperature

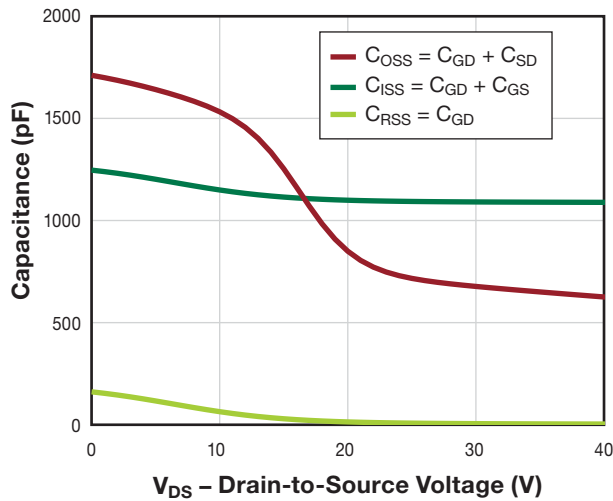


Figure 11. Typical Capacitance

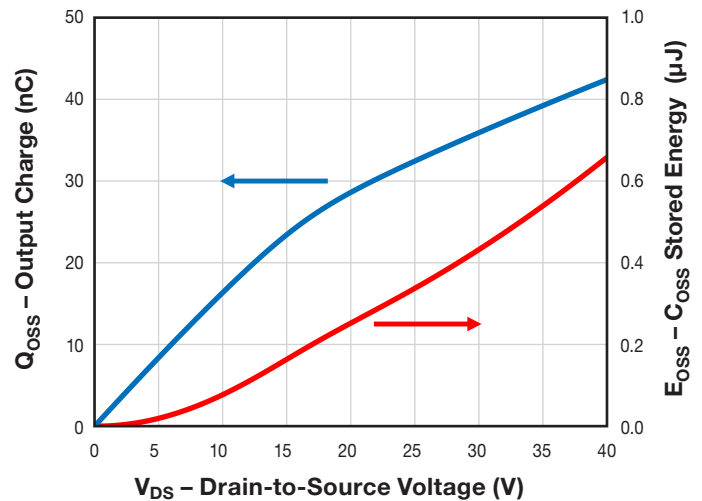


Figure 12. Typical Output Charge and  $C_{OSS}$  Stored Energy

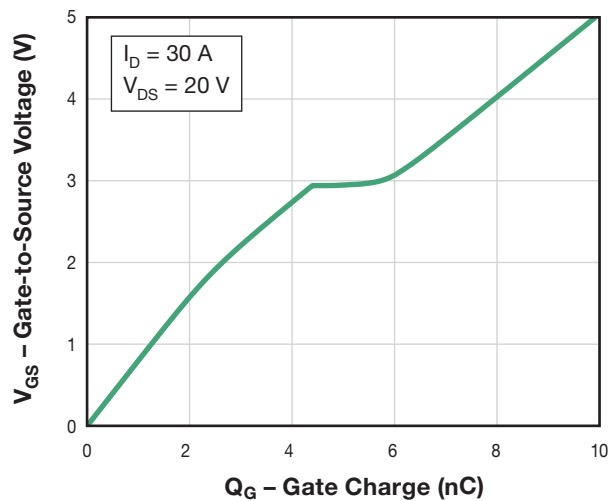


Figure 13. Typical Gate Charge

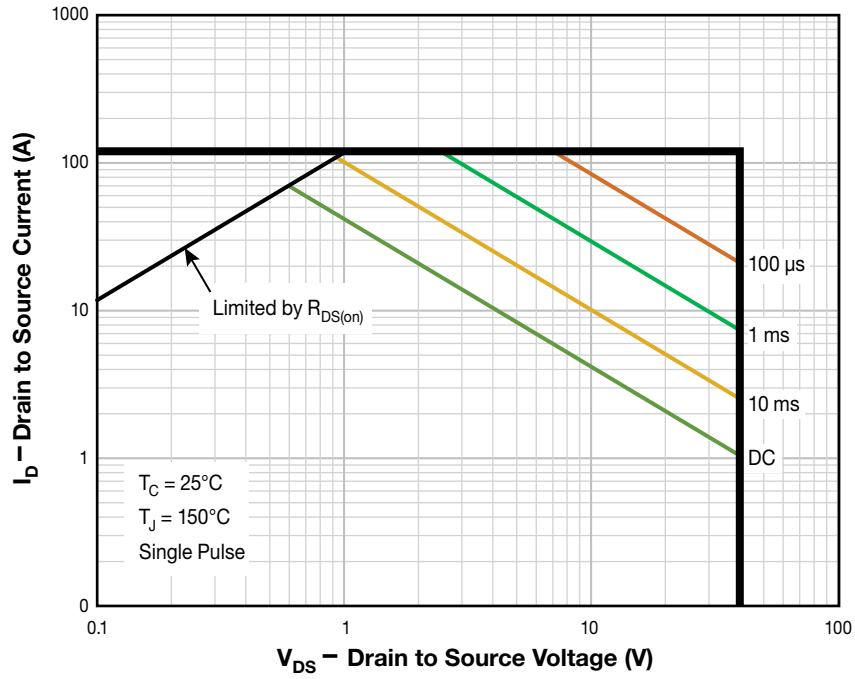


Figure 14. Safe Operating Area

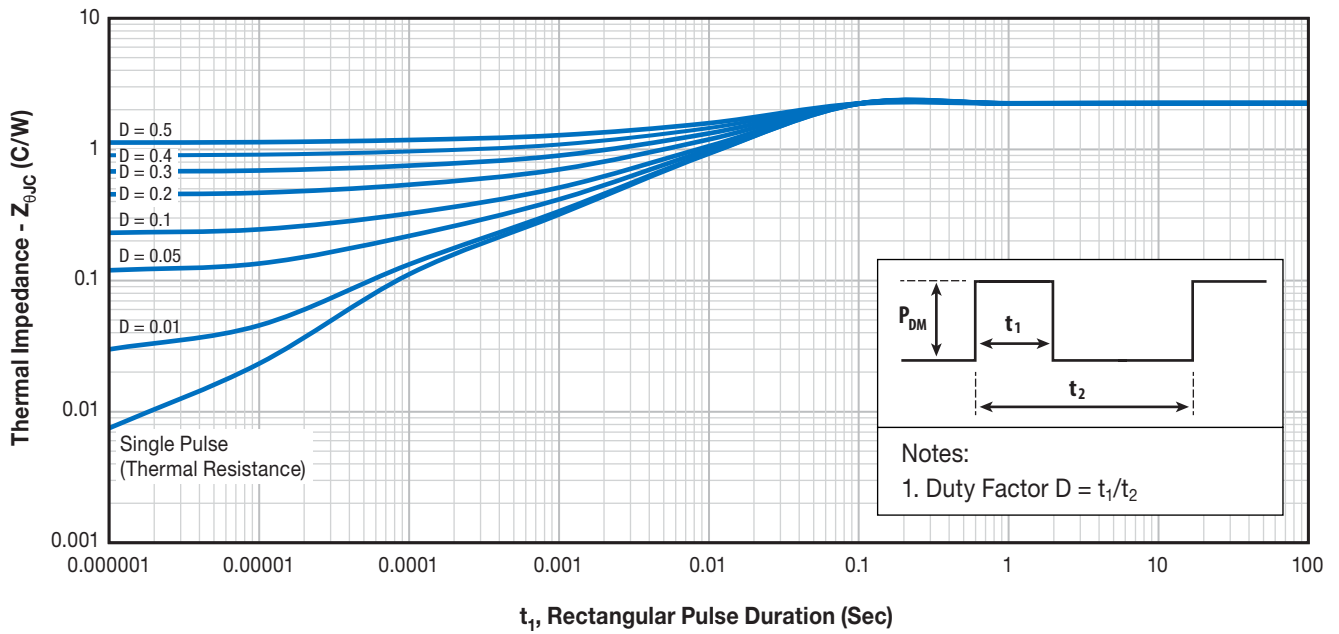
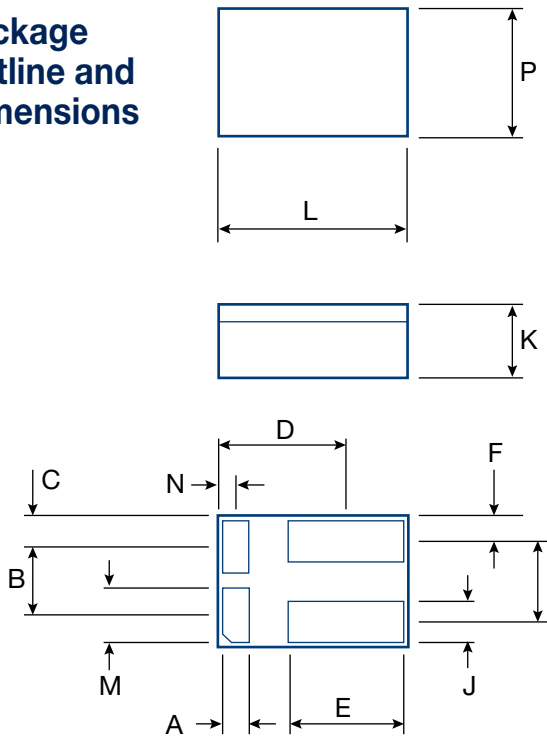


Figure 15. Transient Thermal Impedance, Junction to Case

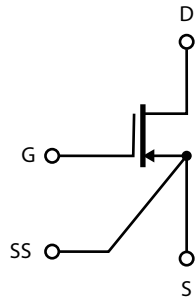
Package Outline and Dimensions



Symbol	Inches		Millimeters		Note
	MIN	MAX	MIN	MAX	
A	0.027	0.037	0.685	0.939	
B	0.073	0.083	1.854	2.108	
C	0.031	0.041	0.784	1.041	
D	0.143	0.153	3.632	3.886	
E	0.129	0.139	3.277	3.531	
F	0.027	0.037	0.686	0.940	
G	0.082	0.092	2.083	2.337	
J	0.050	0.060	1.270	1.524	
K	0.078	0.088	1.981	2.235	Ref. only
L	0.215	0.225	5.461	5.715	
M	0.058	0.068	1.473	1.727	
N	0.016	0.026	0.406	0.660	
P	0.145	0.155	3.683	3.937	

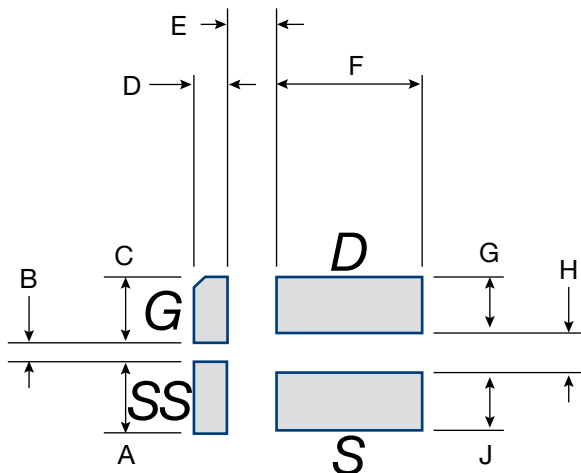
Standard Terminal Pad finish is a solder alloy of 63%Sn 37%Pb.

Package Connections



**NOTE:** SS pin is connected directly to source of internal die.

FSMD-B Footprint for Printed Circuit Board Design



Symbol	Inches		Millimeters		Note
	MIN	MAX	MIN	MAX	
A	0.064	0.074	1.626	1.880	
B	0.010	0.020	0.254	0.508	
C	0.064	0.074	1.626	1.880	
D	0.036	0.046	0.914	1.168	
E	0.034	0.044	0.864	1.118	
F	0.135	0.145	3.429	3.683	
G	0.059	0.069	1.499	1.753	
H	0.020	0.030	0.508	0.762	
J	0.059	0.069	1.499	1.753	

## Notes

- Note 1. Never exceed the absolute maximum  $V_{DS}$  of the device otherwise permanent damage/destruction may result.
- Note 2. Never exceed the absolute maximum  $V_{GS}$  of the device otherwise permanent damage/destruction may result. We recommend a  $V_{GS}$  of 5 V for optimum operation across life and radiation.
- Note 3.  $R_{\theta JA}$  measured with FSMD-B package mounted to double-sided PCB, 0.063" thickness with 1.0 square inches of copper area on the top (mounting side) and a flood etch (3 square inches) on the bottom side.
- Note 4. Measured using four wire (Kelvin) sensing and pulse measurement techniques. Measurement pulse width is 80  $\mu$ s and duty cycle is 1%, maximum.
- Note 5. Guaranteed by design/device construction. Not tested.
- Note 6. The gate charge parameters are measured based on the MIL-STD-750.3471 Condition B. A high speed constant gate current ( $I_{const}$ ) is provided to the Gate of the DUT during the time that the ground switch ( $G_S$ ) is OFF ( $t_{off}$ ). The DUT is switched ON and OFF using ground-sensed switch  $G_S$ . The gate current is adjusted to yield the desired charge per unit time ( $I_{const} \cdot \text{time per division}$ ) on the measuring oscilloscope. The  $G_S$  pulse drive ON time ( $t_{on}$ ) is adjusted for the desired observability of the gate-source voltage ( $V_{GS}$ ) waveform. The maximum duty cycle of the ground switch ( $t_{off}/t_{on}$ ) should be set to 1% maximum. Please note that all gate-related signals are referenced to the "Source Sense" pin on the package. At all times during the measurement, the maximum gate-source voltage is clamped to 5  $V_{DC}$ .



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